

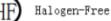
### **Description**

The XPX80P06TU uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 6V. This device is suitable for use as a Battery protection or in other Switching application.

## **Applications**





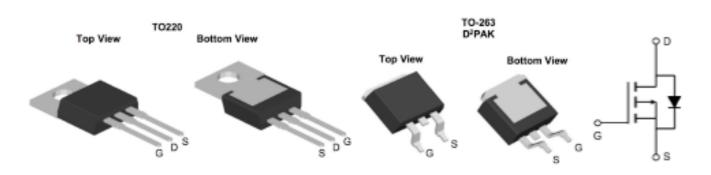


- Motor Drives
- · Uninterruptible Power Supplies
- DC/DC converter
- · General Purpose Applications

#### **General Features**

 $V_{DS} = -60V I_{D} = -82A$ 

RDS(ON) <  $10m\Omega$  @VGS=-10V



Product ID	Pack	Marking	Qty(PCS)
XPX80P06TU	TO-220-3L	XPX80P06TU XXX YYYY	1000
XPX80P06TU	TO-263-3L	XPX80P06TU XXX YYYY	800

### Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-60	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, -V <sub>GS</sub> @ -10V <sup>1</sup>	-82	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, -V <sub>GS</sub> @ -10V <sup>1</sup>	-52	A
Ідм	Pulsed Drain Current <sup>2</sup>	-328	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	450	mJ
<b>I</b> AS	Avalanche Current	52	А
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	110	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient <sup>1</sup>	0.70	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	60	°C/W



### Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-60	-68		V
△BVDSS/△TJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25℃, I <sub>D</sub> =-1mA		-0.035		V/℃
RDS(ON) Static Drain-Source On-Resista	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		10	12	mΩ
TOO(OIV)	Static Brain-Source On-Resistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-15A		13	16	11152
VGS(th)	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.0	-2.1	-3.0	V
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	VGS-VDS , ID2000/(		4.28		mV/℃
IDSS	Drain-Source Leakage Current	$V_{DS}$ =-60V , $V_{GS}$ =0V , $T_{J}$ =25 $^{\circ}$ C			1	uA
1000	Diam-Source Leakage Guirent	V <sub>DS</sub> =-60V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃			5	uд
IGSS	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-20A		50		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.0		Ω
Qg	Total Gate Charge (-4.5V)	V <sub>DS</sub> =-30V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		56		
$Q_{\mathrm{gs}}$	Gate-Source Charge			11		nC
$Q_{\mathrm{gd}}$	Gate-Drain Charge	2071		9		
Td(on)	Turn-On Delay Time			4.5		
Tr	Rise Time	$V_{DD}$ =-30V , $V_{GS}$ =-10V , $R_{G}$ =3 $\Omega$ ,		2.5		no
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =-20A		14.5		ns
T <sub>f</sub>	Fall Time	15 25/1		3.8		
C <sub>iss</sub>	Input Capacitance			3500		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		600		pF
Crss	Reverse Transfer Capacitance			25		
Is	Continuous Source Current <sup>1,5</sup>				-80	Α
ISM	Pulsed Source Current <sup>2,5</sup>	· V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-240	Α
VSD	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25℃			-1.2	V

#### Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width  $\, \leq \, 300 us$  , duty cycle  $\, \leq \, 2\%$
- $3\sqrt{100}$  The EAS data shows Max. rating . The test condition is VDD =-48V, VGS =-10V, L=0.1mH, IAS =-52A
- $4\, {}^{\backprime}$  The power dissipation is limited by  $150\, {}^{\circ}\! {}^{\circ}$  junction temperature
- 5. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation.



### **Typical Characteristics**

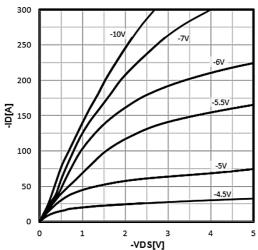


Figure 1. Type. Output Characteristics (Tj=25 ℃)

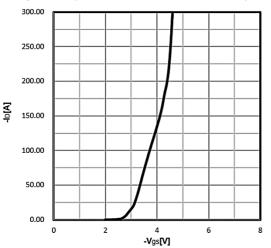


Figure 3. Type. transfer characteristics

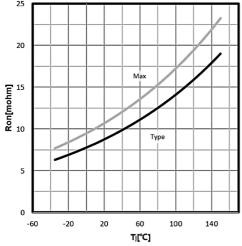


Figure 5. Drain-source on-state resistance RDS(on) =f(Tj); ID =80A; VGS =10V

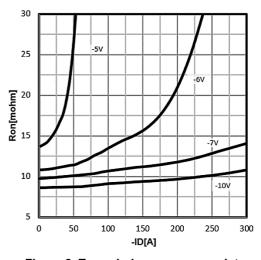


Figure 2. Type. drain-source on resistance

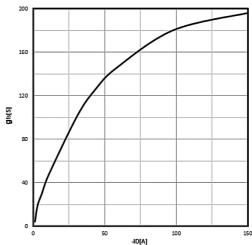


Figure 4. Type. forward transconductance

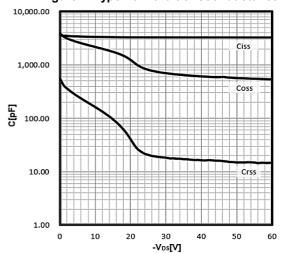


Figure 6 . Body-Diode Characteristics C=f(VDS); VGS =0V; f=1MHz



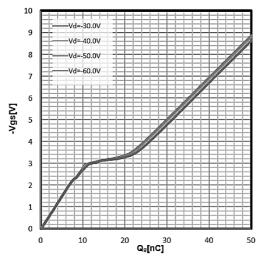


Figure 7. Typ. gate charge VGS =f(Q gate); ID =20A

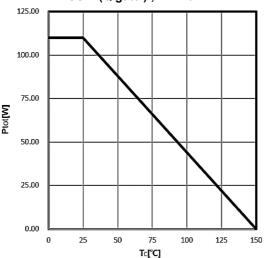


Figure 7. Power Dissipation

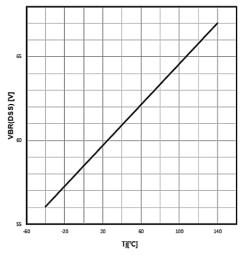


Figure 8. Drain Current Derating VBR(DSS) = f(T j ); I D = 250uA

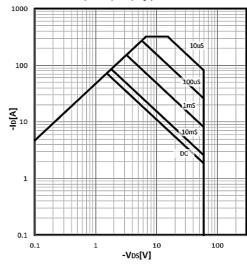


Figure 8. Safe operating area

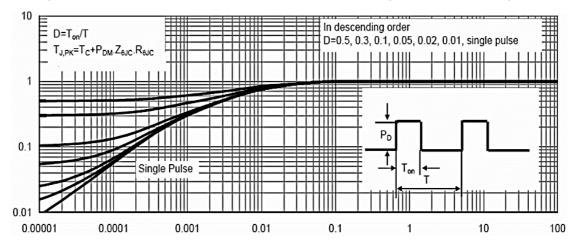
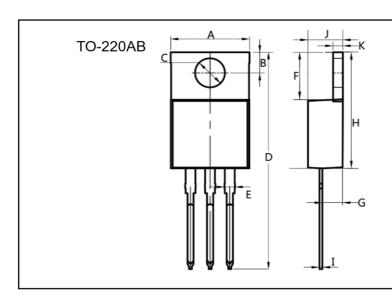


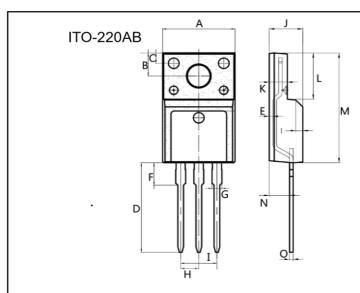
Figure 10. Max. transient thermal impedance

ZthJC =f(tp)

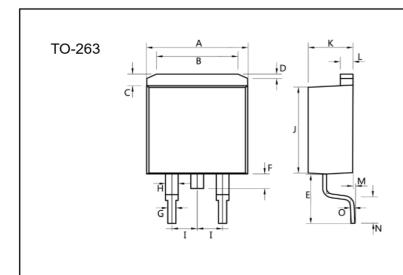




Dim.	Min.	Max.
Α	10.0	10.4
В	2.5	3.0
С	3.5	4.0
D	28.0	30.0
Е	1.1	1.5
F	6.2	6.6
G	2.9	3.3
Н	15.0	16.0
I	0.35	0.45
J	4.3	4.7
K	1.2	1.4
All Dimensions in millimeter		



Dim.	Min.	Max.	
Α	9.9	10.3	
В	2.9	3.5	
С	1.15	1.45	
D	12.75	13.25	
E	0.55	0.75	
F	3.1	3.5	
G	1.25	1.45	
Н	Typ 2.54		
I	Typ 5.08		
J	4.55	4.75	
K	2.4	2. 7	
L	6.35	6.75	
М	15.0	16.0	
N	2.75	3.15	
0	0.45	0.60	
All Dimensions in millimeter			



Dim.	Min.	Max.	
Α	10.0	10. 5	
В	7.25	7.75	
С	1.3	1.5	
D	0.55	0.75	
Е	5.0	6.0	
F	1.4	1.6	
G	0.75	0.95	
Н	1.15	1.35	
I	Typ 2.54		
J	8.4	8.6	
K	4.4	4.6	
L	1.25	1.45	
М	0.02	0.1	
N	2.4	2.8	
0	0.35	0.45	
All Dimensions in millimeter			



#### Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	<b>245℃±5℃</b>	5sec±1sec
Pb-Free device	260℃+0/-5℃	5sec±1sec



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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